

Short Communication

Electrodeposition of ZnO Nanorods as Electron Transport Layer in a Mixed Halide Perovskite Solar Cell

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ZnO nanorod arrays were prepared by electrodeposition from a zinc nitrate precursor on seed layers of the oxide fabricated by spin coating on fluor-tin-oxide (FTO) covered glass substrates. The morphological, structural, and optical properties of the arrays were analyzed by scanning electronic microscope, X-ray diffraction, and ultraviolet-visible spectroscopy. The nanorods were used as electron transport material in CH₃NH₃PbI_{3-x}Cl_x sensitized perovskite solar cells that were characterized by X-ray diffraction. The performance of the cells was investigated using current-voltage measurements. They showed an open circuit voltage of 0.85 V, a short-circuit current of 6.8 mA cm⁻², a fill factor of 0.46 and 2.4% power conversion efficiency under 1 sun of illumination.

1. INTRODUCTION

Organic-inorganic perovskite solar cells have been intensively studied and have recently emerged as a transformative photovoltaic technology within the framework of third generation hybrid photovoltaic devices [1-5]. The power efficiencies of these devices have progressively increased, and a recent study found the key to produce new cost-efficient cells with a world-record performance of 22.1% in small cells and 19.7% in 1-square centimeter cells [6]. The perovskite materials that have been most used for the absorption of solar light and charge separation are hybrid organic-inorganic compounds presenting a 3D crystal structure obeying the general formula CH₃NH₃PbX₃ (X= Cl, Br or I). Photogenerated electron and hole charge collection is done through selective adjacent contact phases that produce a driving force for charge separation. The electron-transporting layer (ETL) is usually a wide bandgap oxide material, and the hole transporting layer (HTL) is usually spiro-

OMeTAD, an organic molecular glass [7]. One interesting aspect of this technology is the easy synthesis of the photoactive components at temperatures lower than 100° C [8]. Furthermore, the hybrid organic-inorganic perovskite material exhibits exceptional characteristics to be used as an absorbent layer, such as a wide absorption spectra interval with high extinction coefficient [9], ambipolar diffusion [10], and long carrier diffusion length [11]. TiO₂ planar electrodes have been mostly studied as hole-blocking electrodes in perovskite-based solar cells. Currently, a mesoporous titania layer is grown on top of a compact layer for further deposition of a perovskite absorber layer [12]. Synthesis of these layers requires high temperature annealing and sintering processes, usually at 500° C. However, low temperatures are needed to reduce production costs and to allow for the possibility of preparing devices on flexible substrates. Alternatively, ZnO is known to have several advantages compared to TiO₂, including a wide direct bandgap and higher electron mobility, which favors transport to the front contact [13, 14]. The facility for preparing a variety of ZnO nanostructures has led to several studies where vertically aligned one-dimensional nanostructures are utilized as photoanodes in solar cells sensitized with dyes [15]. These nanostructures favor electron transport, contributing to diminished electron-hole recombination and improving electron collection towards the external circuit due to the existence of a direct pathway free of grain boundaries [16]. High efficiencies have been reported for planar thin layers of ZnO prepared by spin-coating [17] and ZnO nanowires [18]. A ZnO thin film doped with aluminum deposited by electrospray as an electron-selective layer achieved an efficiency of 12% [19].

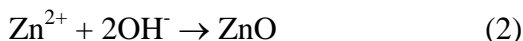
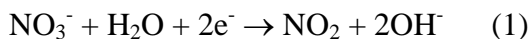
The current work is focused on the electrochemical synthesis of ZnO nanorod nanostructures as ETL. Electrodeposition is a useful and simple technique to form this type of film on conducting substrates at lower temperatures and short deposition times [20]. It also allows for the modulation of morphologies and structural characteristics of the deposits through simple changes in synthesis conditions. CH₃NH₃PbI_{3-x}Cl_x was used as an absorber, taking into account that the incorporation of Cl into an iodide-based structure improves the charge transport and separation kinetics within the perovskite layer [21]. The morphology and structure of the as-prepared films were investigated. Additionally, the FTO/ZnO/CH₃NH₃PbI_{3-x}Cl_x/spiro-OMeTAD/Au solar cell was fabricated and its preliminary efficiency parameters were recorded.

2. EXPERIMENTAL

2.1 ZnO nanorod electrodeposition.

ZnO nanorods (NRs) were prepared on an FTO coated glass which was previously seeded with a very thin ZnO film obtained by spin-coating a 1 mM zinc acetate/0.1 M sodium acetate solution at 1500 rpm. The substrate was cleaned with soap and rinsed with deionized water, followed by sonicating for 5 minutes in ethanol and 5 minutes in acetone. Electrodeposition of ZnO NR arrays was performed during 30 minutes at constant potential in a three-electrode electrochemical cell with the FTO/ZnO seed layer as the working electrode, a Zn sheet as the counter electrode, and saturated Ag/AgCl as the reference. The electrolyte was a 2 mM Zn(NO₃)₂ solution in deionized water

maintained at 70° C. The applied potential was -0.90 V vs the reference for driving the following reactions:



2.2 Perovskite deposition.

$\text{CH}_3\text{NH}_3\text{PbI}_{3-x}\text{Cl}_x$ precursor ink dissolved in dimethylformamide was provided by Ossila (UK). The ink was heated for 2 hours to allow for complete re-dissolution of solutes and then cooled to room temperature before deposition. The substrate was placed into the spin coater, then 30-50 μl of the perovskite was dispensed while spinning at 2000 rpm for 30 seconds. The substrate was then placed onto a hotplate and annealed at 90° for 120 minutes. After annealing, the substrate was transferred into a glovebox environment. Subsequently, the spiro-OMeTAD-based hole transport layer was prepared using the following solution: 97 mg/ml of spiro-OMeTAD in chlorobenzene, lithium-bis(trifluoromethanesulfonyl)imide (Li-TFSI) at a concentration of 175 mg/ml in acetonitrile and TBP at a volumetric percentage of 46.6% in acetonitrile. The final solution was obtained by mixing 1000 μl spiro-OMeTAD, 30.2 μl Li-TFSI, and 9.7 μl TBP. 50 μl of this solution was dispensed and spin coated onto the perovskite at 2000 rpm for 30 s. Finally, a 100 nm-thick gold layer as a back contact was deposited by thermal evaporation. Current-voltage curves were recorded using a Keithley 2400 digital source meter with a 0.10 V/s voltage scan rate. The solar cells were illuminated with a solar simulator (Abet Technology Sun Lite model) under AM 1.5 G conditions. A mask with an aperture diameter of 4 mm delimited the surface. A reference silicon solar cell was used to calibrate the power intensity to 100 mW cm^{-2} .

2.3 Structural, morphological, and optical characterization.

Structural characterization of ZnO nanorods before and after perovskite deposition was carried out through X-ray diffraction measurements. Standard θ -2 θ scans were performed on a Philips PW 180 diffractometer (30 kV, 40 mA, CuK_α radiation with $\lambda = 1.5406 \text{ \AA}$). SEM images were recorded with a JEOL JSM/5900 LV instrument. Optical properties were studied by transmission spectroscopy using a UV/visible SEC 2000 spectra system.

3. RESULTS AND DISCUSSION

Figure 1 shows SEM images of a compact seed layer of ZnO grown by spin coating on the FTO surface and further covered with electrodeposited nanorods of the same oxide from a 2 mM $\text{Zn}(\text{NO}_3)_2$ solution at -0.9 V vs Ag/AgCl. It is observed that the array is highly oriented with an NR density of $1.22 \times 10^8 \text{ cm}^{-2}$. X-ray diffraction patterns are shown in Figure 2 where the diffraction peaks correspond to the hexagonal wurtzite phase of ZnO (JCPDS, 5-0664, ZnO) and the tetragonal phase of

the glass/FTO used as substrate (JCPDS, 41-1445, SnO_2). A substantially high intensity is observed for the (002) diffraction peak, indicating that the ZnO NR array grew along the c-axis normal to the substrate as shown in the SEM images.

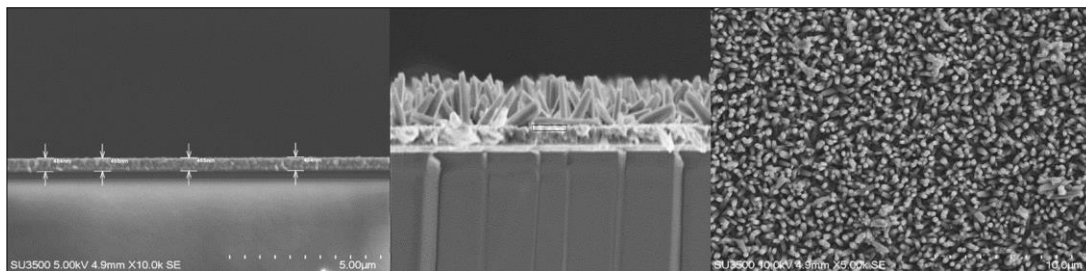


Figure 1. SEM images from left to right: glass/FTO/ZnO seed layer; lateral view of ZnO NR arrays; top view.

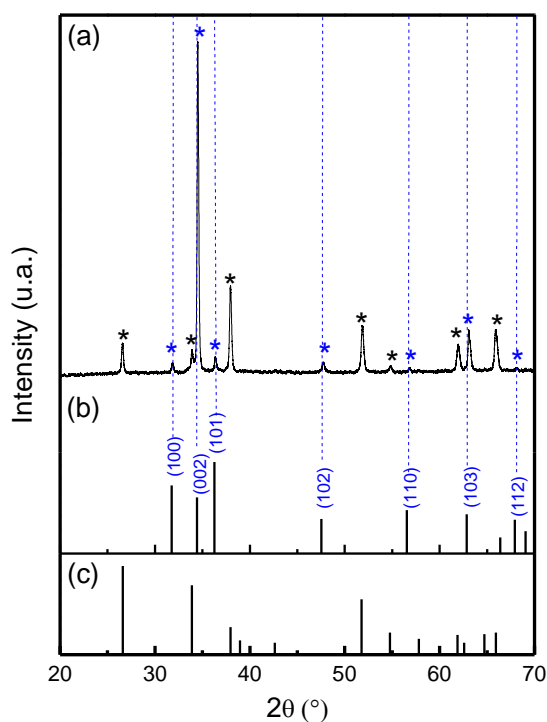


Figure 2. (a) XRD pattern of ZNO NR arrays; (b) and (c) JCPDS of bulk ZnO and SnO_2 , respectively.

The band gap energy can be obtained by a linear fitting from the $(\alpha h\nu)^2$ vs. $h\nu$ plot, and the energy value corresponds to the intercept with the abscissa (Figure 3). This value is 3.38eV, which is very close to the expected room temperature band gap energy of bulk ZnO, which is between 3.2 and 3.4 eV at room temperature (22).

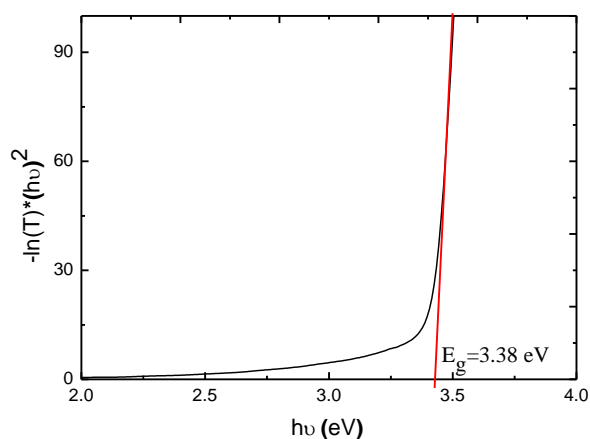


Figure 3. $(\alpha hv)^2$ vs $h\nu$ plot. The intercept with the c axis is E_g .

The ZnO NR array was sensitized by the $\text{CH}_3\text{NH}_3\text{PbI}_{3-x}\text{Cl}_x$ perovskite as described in the experimental section. The corresponding XRD pattern (Figure 4) exhibits reflection peaks at $2\theta = 14.8^\circ$ and 28.47° , which are associated with the (110) and (220) crystallographic perovskite planes (22), respectively.

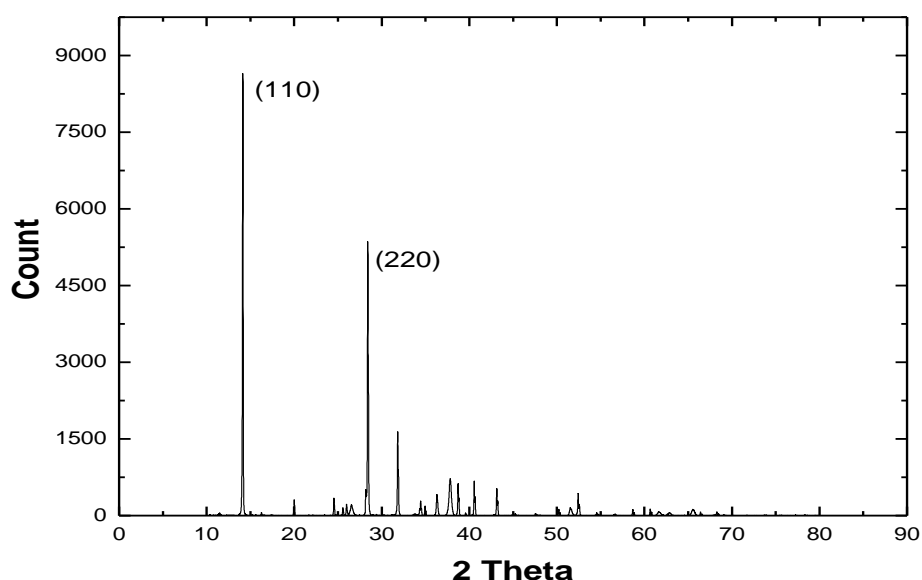


Figure 4. XRD diffractogram of ZnO NRs covered with the $\text{CH}_3\text{NH}_3\text{PbI}_{3-x}\text{Cl}_x$ perovskite.

The sensitized ZnO NR structures were completed by adding a thin layer of spiro-MeTAD and other additives described in the experimental section. A gold contact was evaporated onto the top of the hole transport layer. Cell performance was evaluated by recording J/V curves under illumination equivalent to 1 sun (Figure 5). The device is characterized by a short-circuit (SC) current of 6.8 mA cm^{-2} , open circuit voltage (OCV) of 0.85 V, a fill factor of 0.46 and a power conversion efficiency of

2.4%. In spite of the OCV being an acceptable value, the SC current and the fill factor are low compared to those recently reviewed for 1D ZnO NRs fabricated by hydrothermal methods and used in cells with $\text{CH}_3\text{NH}_3\text{PbI}_3$ as absorber [23]. Efficiency losses can originate from defects in the NR morphology that may block the infiltration of the absorber but also from recombination at the surface and interfacial defects with the oxide, and between ZnO and the perovskite absorber [24, 25].

This low performance can be further improved by optimization of the different steps involved in the building of the cell architecture.

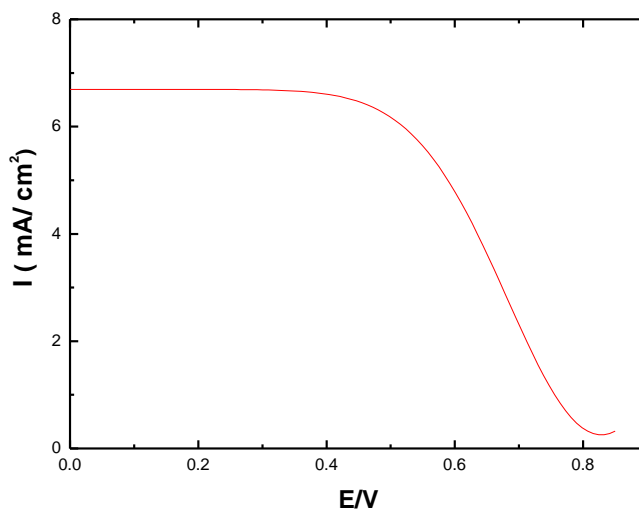


Figure 5. Current-voltage characteristics for glass/FTO/ZnO seed layer/ZnO NRs/ $\text{CH}_3\text{NH}_3\text{PbI}_{3-x}\text{Cl}_x$ spiro-OMeTAD/Au solar cell under 1 sun illumination.

4. CONCLUSIONS

Highly oriented ZnO NRs with c-axis preferred orientation were grown by electrodeposition on a ZnO seed layer and used as obtained for evaluating a solar cell based on $\text{CH}_3\text{NH}_3\text{PbI}_{3-x}\text{Cl}_x$ as an absorber. The measured cell parameters under illumination of 1 sun were $V_{oc} = 0.85$ V, $J_{SC} = 6.8$ mA cm^{-2} and a conversion efficiency of 2.4%. Further work is needed in order to improve these parameters, mainly to reduce charge transfer resistances at the interfaces between the electron transfer layer and the perovskite.

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